Search Notes

Application/Control No.	Applica Reexar
10/721,740	LEE, Y

Applicant(s)/Patent under Reexamination

Examiner Rita R. Patel LEE, YONG JAE Art Unit

1746

SEARCHED				
Class	Subclass	Date	Examiner	
134	186	7/6/2006	RRP	
134	153	7/6/2006	RRP	
134	94.1	7/6/2006	RRP	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH (INCLUDING SEAR)
	DATE	EXMR
EAST key word search.	7/6/2006	RRP
Inventor search.	7/6/2006	RRP